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Capacitor-Free, Dual, 150-mA,

Low-Dropout Voltage Regulator (LDO) in 1,2-mm × 1,2-mm SON Package

FEATURES

- No Input or Output Capacitors Required
- Inrush Current Control
- Low Crosstalk
- Accuracy: 1%
- Input Voltage Range: 1.4 V to 5.5 V
- Multiple Fixed-Output Voltage Combinations Possible from 1.0 V to 3.3 V
- Foldback Current-Limit Protection
- Package: 1,2-mm × 1,2-mm SON-6 (DPQ)

APPLICATIONS

- Wireless Handsets, Smart Phones, Tablets
- Set-Top Boxes (STBs), Cameras, Modems
- Portable Battery-Powered Products

DPQ PACKAGE 1,2-mm x 1,2-mm SON (TOP VIEW)

OUT1	1]	[]	6	EN1
OUT2	2		5	IN
GND	3		4	EN2

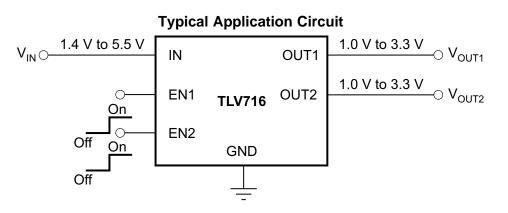
DESCRIPTION

The TLV716 is a family of dual-channel, capacitorfree,150-mA, low-dropout (LDO) voltage regulators with multiple fixed-output options available from 1.0 V to 3.3 V. These devices provide an initial 1% accuracy and 1.5% accuracy over temperature.

The TLV716 family is designed to be stable with or without an input or output capacitor. Eliminating the output capacitor allows for a very small solution size. The TLV716P series provides an active pull-down circuit to quickly discharge the output voltage if the application requires an output capacitor.

The device provides inrush current control during device power-up and enabling. Inrush control provides constant-current charging of the output load during startup, thereby reducing the risk of an undesired overcurrent fault from the input supply or battery.

The TLV716 family is available in a 1,2-mm \times 1,2-mm SON-6 package and is ideal for space-constrained applications.



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TLV716 TLV716P

TEXAS INSTRUMENTS

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

PRODUCT	V _{OUT} ⁽²⁾
TLV716 XX(X)YY(Y) PWWWZ	XX(X) is the nominal output voltage of channel 1. For output voltages with a resolution of 100 mV, two digits are used in the ordering number; otherwise, three digits are used (for example, $18 = 1.8$ V and $185 = 1.85$ V). YY(Y) is the nominal output voltage of channel 2. For output voltages with a resolution of 100 mV, two digits are used in the ordering number; otherwise, three digits are used (for example, $18 = 1.8$ V and $185 = 1.85$ V). P is optional. Use <i>P</i> for devices with an active output discharge. WWW is the package designator. Z is the package quantity. Use <i>R</i> for reel (3000 pieces), and <i>T</i> for tape (250 pieces).

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or visit the device product folder on www.ti.com.

(2) Output voltages from 1.0 V to 3.3 V in 50-mV increments are available through the use of innovative factory OTP programming; minimum order quantities may apply. Contact the factory for details and availability.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

At $T_J = -40^{\circ}$ C to +125°C, unless otherwise noted.

			VALUE		
		MIN	MAX	UNIT	
	IN	-0.3	+6.0	V	
Voltage ⁽²⁾	EN1, EN2	-0.3	V _{IN} + 0.3	V	
Voltago	OUT1, OUT2	-0.3	+3.6 or V _{IN} + 0.3 (whichever is smaller)	V	
Current	OUT1, OUT2	-30	Internally limited	mA	
Output short-circuit duration		li	Indefinite		
T	Operating junction, T_J	-55	+150	°C	
Temperature	Storage, T _{stg}	-55	+150	°C	
Electrostatic discharge (ESD)	Human body model (HBM) QSS 009-105 (JESD22-A114A)		2	kV	
rating	Charged device model (CDM) QSS 009-147 (JESD22-C101B.01)		500	V	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated is not implied. Exposure to absolutemaximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground.

THERMAL INFORMATION⁽¹⁾

		TLV716, TLV716P	
	THERMAL METRIC ⁽²⁾⁽¹⁾	DPQ (SON)	UNITS
		6 PINS	
θ_{JA}	Junction-to-ambient thermal resistance	149.3	
θ _{JCtop}	Junction-to-case (top) thermal resistance	93.0	
θ_{JB}	Junction-to-board thermal resistance	110.1	80 MM
Ψ _{JT}	Junction-to-top characterization parameter	3.4	°C/W
ΨЈВ	Junction-to-board characterization parameter	114.9	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance	91.0	

(1) See the *Power Dissipation* section for more details.

(2) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



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ELECTRICAL CHARACTERISTICS

Over operating temperature range of $T_A = -40^{\circ}$ C to +85°C, $V_{IN} = V_{OUT(TYP)} + 0.5$ V or 2.0 V (whichever is greater), $I_{OUT} = 1$ mA, $V_{EN1} = V_{EN2} = 0.9$ V, and $C_{IN} = C_{OUT1} = C_{OUT2} = 1$ µF, unless otherwise noted. Typical values are at $T_J = +25^{\circ}$ C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IN}	Input voltage range		1.4		5.5	V
		$T_{J} = +25^{\circ}C, V_{OUT} > 1.2 V$	-1%	0.33%	1%	
		$T_{J} = +25^{\circ}C, V_{OUT} \le 1.2 V$	-20		20	mV
V _{OUT}	Output voltage accuracy	$T_{\rm J} = -40^{\circ}$ C to +85°C, $V_{\rm OUT} > 1.2$ V	-1.5%		1.5%	
		$T_J = -40^{\circ}$ C to +85°C, $V_{OUT} \le 1.2$ V	-50		50	mV
I _{OUT}	Output current	Each channel	150			mA
ΔV_{OUT} / ΔV_{IN}	Line regulation	$V_{OUT} + 0.5 V < V_{IN} \le 5.5 V$		0.02	0.2	%/V
ΔV _{OUT} / ΔI _{OUT}	Load regulation	1 mA < I _{OUT} < 150 mA		0.07	0.2	mV/mA
ΔV _{OUT} / ΔI _{OUT}	Cross load regulation	1 mA < I _{OUT} < 150 mA		0.005	0.066	mV/mA
		I_{OUT} = 150 mA, 1.0 V ≤ V_{OUT} < 1.2 V		0.78	1	V
		I_{OUT} = 150 mA, 1.2 V ≤ V_{OUT} < 1.8 V		0.6	0.9	V
		I_{OUT} = 150 mA, 1.8 V ≤ V_{OUT} < 2.1 V		0.35	0.575	V
V _{DO}	Dropout voltage	I_{OUT} = 150 mA, 2.1 V ≤ V_{OUT} < 2.5 V		0.29	0.48	V
		I_{OUT} = 150 mA, 2.5 V ≤ V_{OUT} < 3.0 V		0.23	0.45	V
		I_{OUT} = 150 mA, 3.0 V ≤ V_{OUT} < 3.3 V		0.21	0.42	V
V _{HI}	Enable high voltage		0.9		V _{IN}	V
V _{LO}	Enable low voltage		0		0.4	V
R _{PD}	Output pull-down resistance	TLV716P only		120		Ω
I _{CL}	Output current limit	$V_{IN} = V_{OUT(TYP)} + 0.5 V \text{ or } 2.1 V$ (whichever is greater)	160		500	mA
I _{SC}	Output short current limit	V _{OUT} = 0 V		40		mA
I _{GND}	Ground pin current	Per channel, $I_{OUT} = 0$ mA, $V_{IN} = 5.5$ V		50	75	μA
I _{SHUTDOWN}	Shutdown current	Per channel, V_{IN} = 5.5 V, T_J = +25°C		0.1	1	μA
PSRR	Dever eventy rejection ratio	$f = 100 \text{ Hz}, \text{ V}_{\text{OUT}} = 2.8 \text{ V}, \text{ I}_{\text{OUT}} = 30 \text{ mA}$		80		dB
POKK	Power-supply rejection ratio	f = 10 kHz, V_{OUT} = 2.8 V, I_{OUT} = 30 mA		46		dB
V _N	Output noise voltage	utput noise voltage BW = 10 Hz to 100 kHz, V _{OUT} = 1.8 V, 7 $V_{IN} = 2.3$ V, $I_{OUT} = 10$ mA 7		70		μV_{RMS}
	Startup time ⁽¹⁾	$V_{OUT} = 1.0 \text{ V}, I_{OUT} = 150 \text{ mA}$		170		μs
t _{STR}		$V_{OUT} = 3.3 \text{ V}, \text{ I}_{OUT} = 150 \text{ mA}$		900		μs
т	Thormal chutdown town croture	Shutdown, temperature increasing		+158		°C
T _{SD}	Thermal shutdown temperature	Reset, temperature decreasing		+140		°C
TJ	Operating Junction Temperature		-40		+125	°C

(1) Startup time = time from EN assertion to $0.98 \times V_{OUT(NOM)}$.

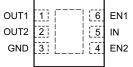
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PIN CONFIGURATION

DPQ PACKAGE						
1,2-mm × 1,2-mm SON-6						
(TOP VIEW)						



PIN DESCRIPTIONS

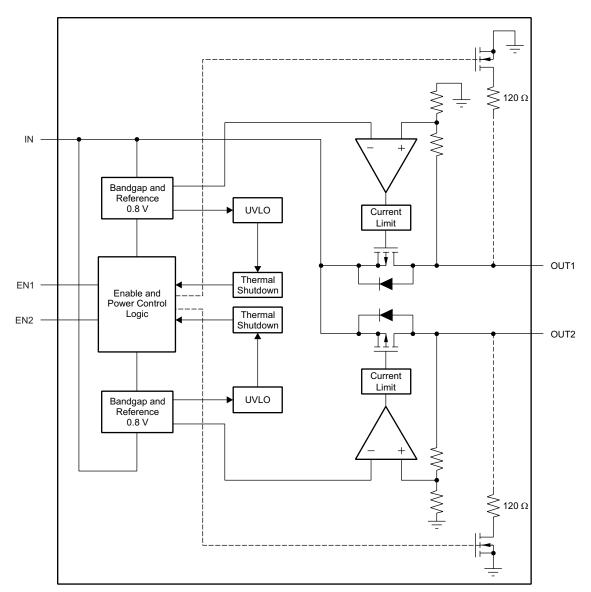
NAME	PIN NO.	DESCRIPTION
OUT1	1	Regulated output voltage pin. See the <i>Input and Output Capacitor Requirements</i> section in the <i>Application Information</i> for more details.
OUT2	2	Regulated output voltage pin. See the <i>Input and Output Capacitor Requirements</i> section in the <i>Application Information</i> for more details.
GND	3	Ground pin.
EN2	4	Enable pin for regulator 2. Driving EN2 over 0.9 V turns on regulator 2. Driving EN2 below 0.4 V places regulator 2 into shutdown mode.
IN	5	Input pin. See the Input and Output Capacitor Requirements section in the Application Information for more details.
EN1	6	Enable pin for regulator 1. Driving EN1 over 0.9 V turns on regulator 1. Driving EN1 below 0.4 V places regulator 1 into shutdown mode.
_	PAD	Connecting the thermal pad to the ground plane improves the thermal performance.



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NOTE: Dashed lines are for the TLV716P only.

TLV716 TLV716P

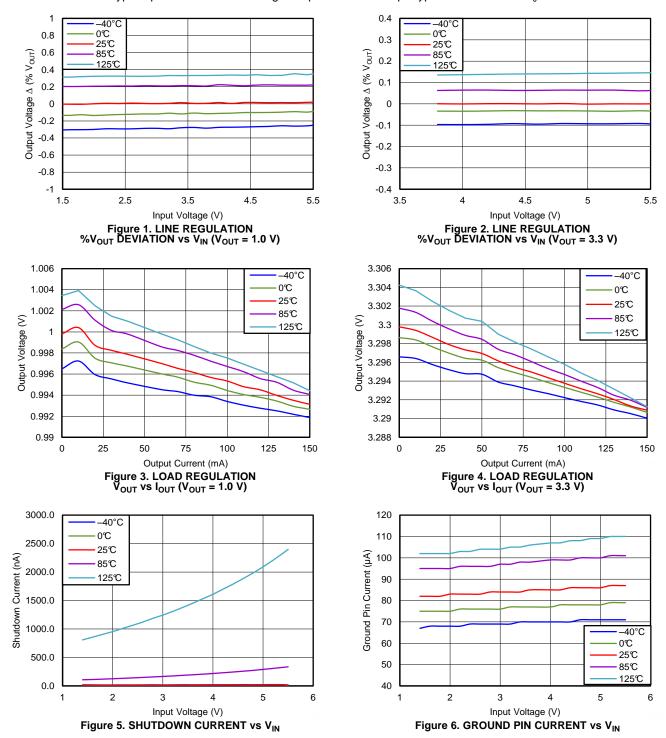
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TYPICAL CHARACTERISTICS

Over operating temperature range of $T_J = -40^{\circ}$ C to +125°C, $V_{IN} = V_{OUT(TYP)} + 0.5$ V or 2.0 V (whichever is greater), $V_{EN1} = V_{EN2} = V_{IN}$, $I_{OUT1} = I_{OUT2} = 10$ mA, $C_{IN} = 1 \ \mu$ F, $C_{OUT1} = 1 \ \mu$ F, and $C_{OUT2} = 1 \ \mu$ F, unless otherwise noted. Output current plots show typical performance with a single output current sweep. Typical values are at $T_J = +25^{\circ}$ C.



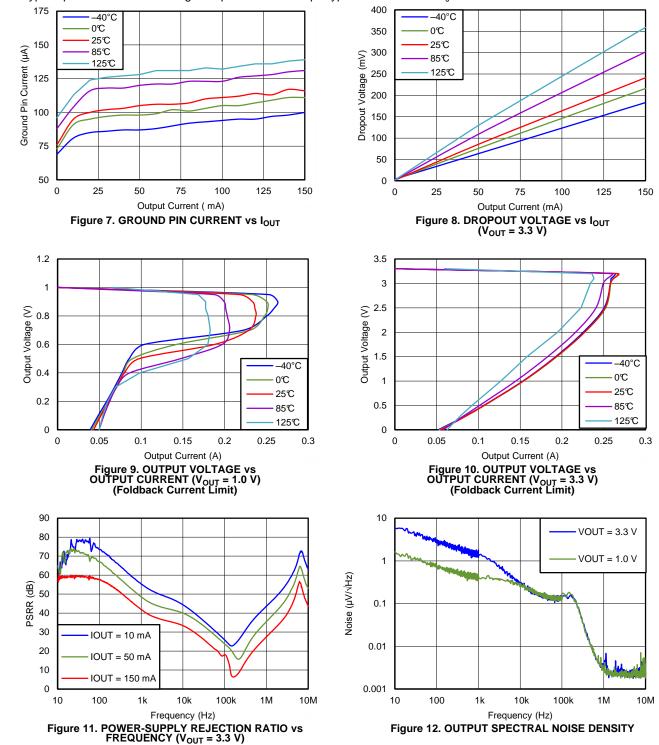


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TYPICAL CHARACTERISTICS (continued)

Over operating temperature range of $T_J = -40^{\circ}$ C to $+125^{\circ}$ C, $V_{IN} = V_{OUT(TYP)} + 0.5$ V or 2.0 V (whichever is greater), $V_{EN1} = V_{EN2} = V_{IN}$, $I_{OUT1} = I_{OUT2} = 10$ mA, $C_{IN} = 1 \ \mu$ F, $C_{OUT1} = 1 \ \mu$ F, and $C_{OUT2} = 1 \ \mu$ F, unless otherwise noted. Output current plots show typical performance with a single output current sweep. Typical values are at $T_J = +25^{\circ}$ C.



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TYPICAL CHARACTERISTICS (continued) Over operating temperature range of $T_J = -40^{\circ}$ C to $+125^{\circ}$ C, $V_{IN} = V_{OUT(TYP)} + 0.5$ V or 2.0 V (whichever is greater), $V_{EN1} = V_{EN2} = V_{IN}$, $I_{OUT1} = I_{OUT2} = 10$ mA, $C_{IN} = 1 \mu$ F, $C_{OUT1} = 1 \mu$ F, and $C_{OUT2} = 1 \mu$ F, unless otherwise noted. Output current plots show typical performance with a single output current sweep. Typical values are at $T_J = +25^{\circ}$ C. $$\begin{split} V_{\text{IN}} &= 2 \text{ V to 3 V in 5 } \mu\text{s} \\ V_{\text{OUT}} &= 1 \text{ V} \\ I_{\text{OUT}} &= 30 \text{ mA} \\ C_{\text{IN}} &= \text{none} \\ C_{\text{OUT}} &= \text{none} \end{split}$$ $$\begin{split} & V_{\text{IN}} = 2 \text{ V to } 3 \text{ V in 5 } \mu\text{s} \\ & V_{\text{OUT}} = 1 \text{ V} \\ & I_{\text{OUT}} = 30 \text{ mA} \\ & C_{\text{IN}} = \text{none} \\ & C_{\text{OUT}} = 1 \, \mu\text{F} \end{split}$$ V_{IN} (1 V/div) V_{IN} (1 V/div) V_{OUT1} (20 mV/div) V_{OUT1} (20 mV/div) V_{OUT2} (20 mV/div) V_{OUT2} (20 mV/div) Time (20 µs/div) Time (20 µs/div) Figure 13. LINE TRANSIENT Figure 14. LINE TRANSIENT V_{IN} (1 V/div) I_{OUT1} (100 mA/div) V_{OUT1} (20 mV/div) V_{OUT1} (100 mV/div) V_{OUT2} (100 mV/div) $V_{IN} = 3.5 V \text{ to } 4.5 V \text{ in } 5 \mu \text{s}$ $V_{OUT} = 3.3 V$ $I_{OUT} = 30 \text{ mA}$ $C_{IN} = \text{none}$ $C_{OUT} = 1 \mu \text{F}$ I_{OUT1} = 0 mA \rightarrow 150 mA \rightarrow 0 mA I_{OUT2} = 30 mA I_{OUT2} = 30 mA V_{IN} = 2 V, V_{OUT} = 1 V C_{IN} = 0.22 μF, C_{OUT} = 0.22 μF Time (50 µs/div) Time (200 µs/div) Figure 15. LINE TRANSIENT Figure 16. LOAD TRANSIENT V_{IN} = 3.8 V short V_{OUT} to GND C_{OUT}= none V_{IN} (2 V/div) I_{OUT1} (100 mA/div) V_{OUT1} (2 V/div) V_{OUT1} (100 mV/div) V_{OUT2} (100 mV/div) $$\begin{split} & | & \\ I_{OUT1} = 0.1 \text{ mA} \rightarrow 150 \text{ mA} \rightarrow 0.1 \text{ mA} \\ I_{OUT2} = 30 \text{ mA} \\ V_{IN} = 4.3 \text{ V}, V_{OUT} = 3.3 \text{ V} \\ C_{IN} = 0.22 \text{ µF}, C_{OUT} = 0.22 \text{ µF} \end{split}$$ I_{OUT1} (100 mA/div) Time (100 µs/div) Time (20 µs/div)

Figure 17. LOAD TRANSIENT

Figure 18. FOLDBACK CURRENT LIMIT

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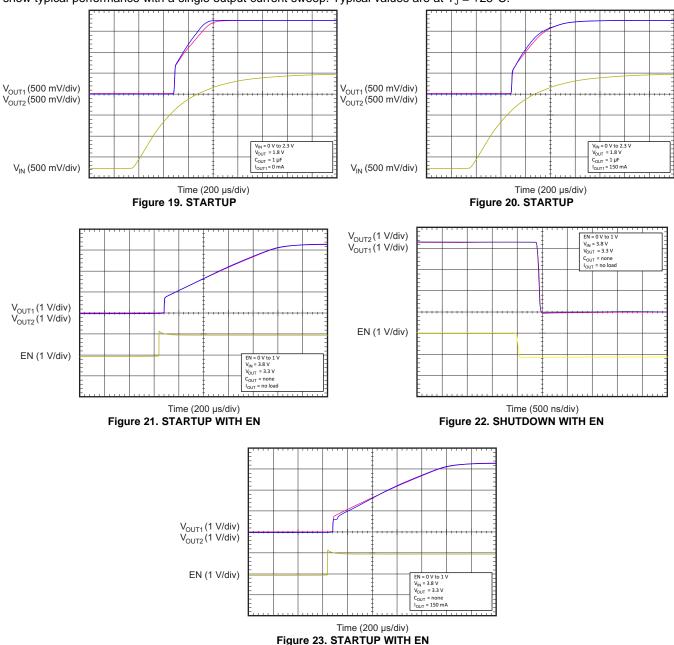


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TYPICAL CHARACTERISTICS (continued)

Over operating temperature range of $T_J = -40^{\circ}$ C to $+125^{\circ}$ C, $V_{IN} = V_{OUT(TYP)} + 0.5$ V or 2.0 V (whichever is greater), $V_{EN1} = V_{EN2} = V_{IN}$, $I_{OUT1} = I_{OUT2} = 10$ mA, $C_{IN} = 1 \mu$ F, $C_{OUT1} = 1 \mu$ F, and $C_{OUT2} = 1 \mu$ F, unless otherwise noted. Output current plots show typical performance with a single output current sweep. Typical values are at $T_J = +25^{\circ}$ C.



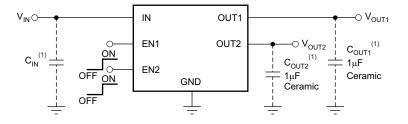


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APPLICATION INFORMATION

The TLV716 and TLV716P belong to a family of dual-channel, capacitor-free, 150-mA, low-dropout voltage (LDO) regulators. These devices can be used with or without external capacitors and are available in a 1,2-mm × 1,2-mm package, making these devices a very small solution size for dual-channel, low-dropout (LDO) regulators. This family of LDO regulators offers current-limit and thermal protection, and is specified from -40°C to +85°C. Figure 24 shows an application circuit for this family of devices.



(1) Optional.

Figure 24. Typical Application Circuit

CAPACITOR-FREE OPERATION

The TLV716 is stable without the use of input or output capacitors. This functionality results in a reduction of component count, cost, and solution size. In addition, without the need of external capacitors, the TLV716 ultrasmall, 1,2-mm × 1,2-mm DPQ package optimizes the solution size for board space-constrained applications. To optimize device ac performance, an input and output capacitor is recommended, as described in the *Input and Output Capacitor Requirements* section.

INPUT AND OUTPUT CAPACITOR REQUIREMENTS

The TLV716 uses an advanced internal control loop to obtain stable operation both with or without the use of input or output capacitors as high as 100- μ F. The dynamic performance of the device is improved with the use of an output capacitor. An output capacitance of 0.1 μ F or larger generally provides good dynamic response. X5R-and X7R-type ceramic capacitors are recommended because these capacitors have minimal variation in value and equivalent series resistance (ESR) over temperature.

Although an input capacitor is not required for stability, good analog design practice is to connect a $0.1-\mu F$ to $1-\mu F$ capacitor from IN to GND. This capacitor counteracts input source impedance and improves supply transient response, input ripple, and PSRR. A higher value capacitor may be necessary if large, fast, rise-time load transients are anticipated or if the device is located several inches from the input power source.

BOARD LAYOUT RECOMMENDATIONS TO IMPROVE PSRR AND NOISE PERFORMANCE

If used, place the input and output capacitors as close to the device pins as possible. To improve ac performance (such as PSRR, output noise, and transient response), TI recommends that for V_{IN} and V_{OUT} , the ground planes are connected only at the GND pin of the device. In addition, connect the ground connection for the output capacitor directly to the GND pin of the device.



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INTERNAL CURRENT LIMIT

The TLV716 has an internal foldback current limit that helps protect the regulator during fault conditions. The current supplied by the device gradually reduces while the output voltage decreases. When the output is connected to ground, the LDO supplies a typical current of 40 mA. When in current limit, the output voltage is not regulated and $V_{OUT} = I_{OUT} \times R_{LOAD}$; see Figure 10 and Figure 11. The PMOS pass transistor dissipates [($V_{IN} - V_{OUT}$) × I_{LIMIT}] until thermal shutdown is triggered and the device turns off. When the device cools down, the internal thermal shutdown circuit turns on the device. If the fault condition continues, the device cycles between current limit and thermal shutdown. See the *Thermal Information* section for more details.

The TLV716 PMOS pass element has a built-in body diode that conducts current when the voltage at OUT exceeds the voltage at IN. This current is not limited, so if extended reverse voltage operation is anticipated, external limiting to 5% of the rated output current is recommended. A small schottky diode connected with the anode to OUT and the cathode to IN can accomplish this limiting.

SHUTDOWN

The enable pin (EN) is active high. The device is enabled when the EN pin goes above 0.9 V. This relatively low value of voltage required to turn the LDO regulator on can be used to enable the device with the general-purpose input/output (GPIO) of recent processors whose GPIO voltage is lower than traditional microcontrollers.

The device is turned off when the EN pin is held at less than 0.4 V. When shutdown capability is not required, the EN pin can connected to the IN pin. The TLV716P will pull down the output with a 120Ω resistor when the EN pin falls below 0.4 V.

DROPOUT VOLTAGE

The TLV716 and TLV716P use a PMOS pass transistor to achieve low dropout. When $(V_{IN} - V_{OUT})$ is less than the dropout voltage (V_{DO}) , the PMOS pass device is in the linear region of operation and the input-to-output resistance is the R_{DS(ON)} of the PMOS pass element. V_{DO} scales approximately with the output current because the PMOS device behaves like a resistor in dropout.

As with any linear regulator, PSRR and transient response are degraded as $(V_{IN} - V_{OUT})$ approaches dropout.

UNDERVOLTAGE LOCKOUT (UVLO)

The TLV716 and TLV716P use an undervoltage lockout circuit (1.3 V, typical) to keep the output shut off until the internal circuitry is operating properly.

THERMAL INFORMATION

Thermal protection disables the output when the junction temperature rises to approximately +158°C, allowing the device to cool. When the junction temperature cools to approximately +140°C, the output circuitry is again enabled. Depending on power dissipation, thermal resistance, and ambient temperature, the thermal protection circuit may cycle on and off. This cycling limits the dissipation of the regulator, protecting it from damage as a result of overheating.

Any tendency to activate the thermal protection circuit indicates excessive power dissipation or an inadequate heatsink. For reliable operation, junction temperature should be limited to +125°C maximum. To estimate the margin of safety in a complete design, increase the ambient temperature until the thermal protection is triggered; use worst-case loads and signal conditions. The ambient temperature at which thermal shutdown occurs on the device is 33°C higher (158°C - 125°C) than the maximum recommended operating conditions.

The internal protection circuitry of the TLV716 and TLV716P is designed to protect against overload conditions. This circuitry is not intended to replace proper PCB layout and heatsinking. Continuously running the device into thermal shutdown degrades reliability.

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POWER DISSIPATION

The ability to remove heat from a die is different for each package type, presenting different considerations in the printed circuit board (PCB) layout. The copper PCB area around the device that is free of other components moves the heat from the device to ambient air. Performance data for JEDEC-low and high-K boards are given in the Thermal Information table. Using heavier copper increases effectiveness in removing heat from the device.

Power dissipation (P_D) is equal to the product of the output current and the voltage drop across both output pass elements, as shown in Equation 1:

$$\mathsf{P}_{\mathsf{D}} = (\mathsf{V}_{\mathsf{IN}} - \mathsf{V}_{\mathsf{OUT1}}) \times \mathsf{I}_{\mathsf{OUT1}} + (\mathsf{V}_{\mathsf{IN}} - \mathsf{V}_{\mathsf{OUT2}}) \times \mathsf{I}_{\mathsf{OUT2}}$$

The maximum ambient temperature that the device can operate within the maximum T_J operating temperature of +125°C depends on the thermal impedance and the total power dissipated within the device. Figure 25 and Figure 26 show maximum ambient temperature verses output current for two different LDO configurations. Figure 25 shows the maximum ambient temperature with $V_{IN} = 3.3 \text{ V}$, $V_{OUT1} = 1.8 \text{ V}$, and $V_{OUT2} = 1.0 \text{ V}$ versus I_{OUT1} . Figure 26 shows the maximum ambient temperature with $V_{IN} = 5.0 \text{ V}$, $V_{OUT1} = 3.3 \text{ V}$, and $V_{OUT2} = 1.8 \text{ V}$ versus I_{OUT1} .

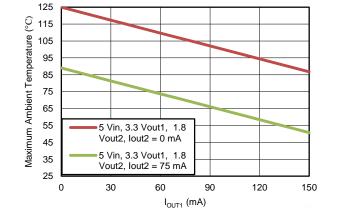


Figure 25. Maximum Ambient Temperature vs Output Current ($V_{IN} = 5.0 \text{ V}, V_{OUT1} = 3.3 \text{ V}, V_{OUT2} = 1.8 \text{ V}$)

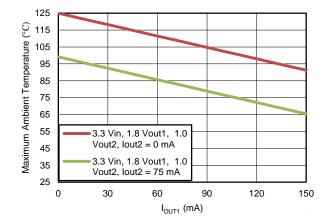


Figure 26. Maximum Ambient Temperature vs Output Current $(V_{IN} = 3.3 \text{ V}, V_{OUT1} = 1.8 \text{ V}, V_{OUT2} = 1.0 \text{ V})$



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REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (June 2013) to Revision A



30-Sep-2013

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing		Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TLV716120275PDPQR	ACTIVE	X2SON	DPQ	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	EI	Samples
TLV716120275PDPQT	ACTIVE	X2SON	DPQ	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	EI	Samples
TLV7162818PDPQR	ACTIVE	X2SON	DPQ	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CW	Samples
TLV7162818PDPQT	ACTIVE	X2SON	DPQ	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CW	Samples
TLV7162828PDPQR	ACTIVE	X2SON	DPQ	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	СХ	Samples
TLV7162828PDPQT	ACTIVE	X2SON	DPQ	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	СХ	Samples
TLV7163030PDPQR	ACTIVE	X2SON	DPQ	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CY	Samples
TLV7163030PDPQT	ACTIVE	X2SON	DPQ	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CY	Samples
TLV7163318PDPQR	ACTIVE	X2SON	DPQ	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CZ	Samples
TLV7163318PDPQT	ACTIVE	X2SON	DPQ	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CZ	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)



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30-Sep-2013

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

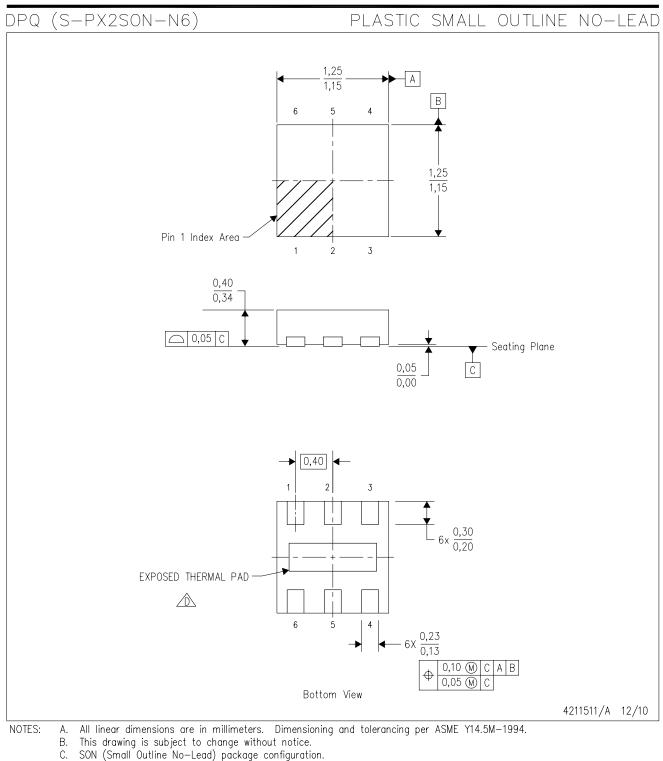
⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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MECHANICAL DATA



The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.



DPQ (S-PX2SON-N6)

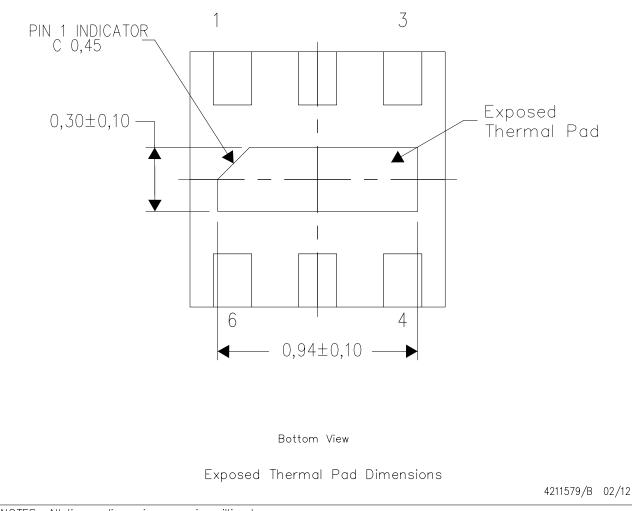
PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

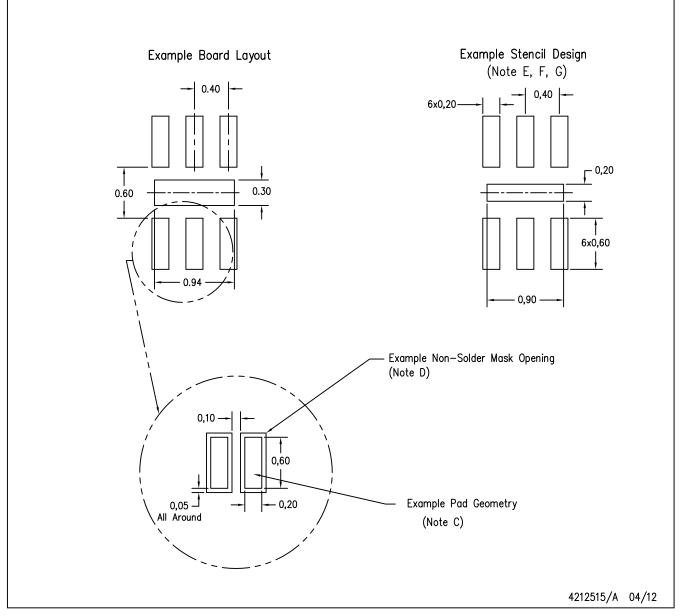


NOTES: All linear dimensions are in millimeters





PLASTIC SMALL OUTLINE NO-LEAD



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
- E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
- F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.



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